Search	Notes	

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Application/Control No	Applicant(s)/Patent under Reexamination	
10/516,084	BAST ET AL.	
Examiner	Art Unit	
Hoai-An D. Nguyen	2858	

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SEARCH NOT (INCLUDING SEARCH		)
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Consulted with Primary Examiner A. Deb.	6/1/2006	HADN
Consulted with SPE B. Sircus.	6/1/2006	HADN
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